

NI 6115/6120 Specifications

This document lists the specifications for the NI 6115/6120. For the most current edition of this document, refer to ni.com/manuals. Refer to the *DAQ Getting Started Guide* for more information about accessing documents on the NI-DAQ CD.

The following specifications are typical at 25 °C unless otherwise noted.

Analog Input

Input Characteristics

Number of channels 4 pseudodifferential

Type of ADC

Resolution

NI 6115 12 bits, 1 in 4,096

NI 6120 16 bits, 1 in 65,536

Pipeline

NI 6115 2

NI 6120 0

Sampling rate

Maximum

NI 6115 10 million S/s

NI 6120 800 kS/s

Minimum

NI 6115 20 kS/s

NI 6120 No minimum

Input impedance

AI + to AI -

Range $\leq \pm 10$ V 1 M Ω in parallel with
100 pF

Range $> \pm 10$ V 10 k Ω in parallel with
40 pF

AI - to AI GND

NI 6115 100 G Ω in parallel with
10 nF

NI 6120 100 G Ω in parallel with
100 pF

AI + to AI GND

NI 6115 100 G Ω in parallel with
100 pF

NI 6120 100 G Ω in parallel with
100 pF

Input bias current ± 300 pA

Input offset current ± 200 pA

Input coupling DC/AC

Max working voltage for all analog input channels

Positive input (AI +) ± 42 V for ± 20 V and
 ± 42 V ranges; ± 11 V
for other ranges

Negative input (AI -) ± 2.5 V

Overvoltage protection

(AI +, AI -) ± 42 V

Input current during

overvoltage conditions ± 20 mA max

Input FIFO size 16 or 32 MS

Data transfers DMA, interrupts,
programmed I/O

DMA mode Scatter-gather

DC Transfer Characteristics

INL

NI 6115 ± 0.35 LSB typ,
 ± 1 LSB max

NI 6120 ± 2.5 LSB max

DNL

NI 6115 ± 0.25 LSB typ,
 ± 1 LSB max

NI 6120 0.75 LSB typ,
no missing codes

Offset, gain errorRefer to Tables 1 and 2¹

Table 1. NI 6115 Analog Input DC Accuracy Information

| Nominal Range (V) | Absolute Accuracy | | | | | | Relative Accuracy | | |
|-------------------|-------------------|--------|--------------|---------------------------|----------|-------------------|---------------------------------------|-----------------|----------|
| | % of Reading | | Offset* (mV) | Noise + Quantization (mV) | | Temp Drift (%/°C) | Absolute Accuracy at Full Scale (±mV) | Resolution (mV) | |
| | 24 Hours | 1 Year | | Single Pt. | Averaged | | | Single Pt. | Averaged |
| ±42 | 0.35 | 0.35 | 33 | 42 | 3.6 | 0.023 | 210.0 | 48 | 4.8 |
| ±20 | 0.27 | 0.27 | 13 | 17 | 1.4 | 0.023 | 69 | 19 | 1.9 |
| ±10 | 0.026 | 0.028 | 6.7 | 8.3 | 0.72 | 0.0006 | 10 | 10 | 1.0 |
| ±5 | 0.016 | 0.018 | 3.4 | 4.2 | 0.36 | 0.0006 | 4.7 | 4.8 | 0.48 |
| ±2 | 0.036 | 0.038 | 1.3 | 1.8 | 0.16 | 0.0006 | 2.2 | 2.0 | 0.20 |
| ±1 | 0.043 | 0.045 | 0.68 | 1.1 | 0.09 | 0.0006 | 1.2 | 1.2 | 0.12 |
| ±0.5 | 0.058 | 0.060 | 0.35 | 0.69 | 0.061 | 0.0006 | 0.71 | 0.80 | 0.080 |
| ±0.2 | 0.10 | 0.11 | 0.15 | 0.43 | 0.039 | 0.0006 | 0.40 | 0.51 | 0.051 |

* The offset might degrade by 2.25 LSB with filter enabled.

Table 2. NI 6120 Analog Input DC Accuracy Information

| Nominal Range (V) | Absolute Accuracy | | | | | | Relative Accuracy | | |
|-------------------|-------------------|--------|--------------|---------------------------|----------|-------------------|---------------------------------------|-----------------|----------|
| | % of Reading | | Offset* (µV) | Noise + Quantization (µV) | | Temp Drift (%/°C) | Absolute Accuracy at Full Scale (±mV) | Resolution (µV) | |
| | 24 Hours | 1 Year | | Single Pt. | Averaged | | | Single Pt. | Averaged |
| ±42 | 0.16 | 0.16 | 8,400 | 6,100 | 550 | 0.011 | 87 | 7,200 | 720 |
| ±20 | 0.14 | 0.14 | 3,300 | 2,400 | 220 | 0.011 | 31 | 2,900 | 290 |
| ±10 | 0.033 | 0.034 | 1,700 | 1,200 | 110 | 0.0006 | 5.1 | 1,400 | 140 |
| ±5 | 0.035 | 0.037 | 840 | 750 | 69 | 0.0006 | 2.7 | 900 | 90 |
| ±2 | 0.039 | 0.041 | 370 | 340 | 31 | 0.0006 | 1.2 | 410 | 41 |
| ±1 | 0.077 | 0.079 | 280 | 200 | 18 | 0.0006 | 1.1 | 240 | 24 |
| ±0.5 | 0.10 | 0.10 | 180 | 110 | 10 | 0.0006 | 0.69 | 130 | 13 |
| ±0.2 | 0.12 | 0.12 | 93 | 54 | 5.1 | 0.0006 | 0.34 | 68 | 6.8 |

* The offset might degrade by 8 LSB with filter enabled and by 1 LSB when sampling above 500 kS/s.

¹ Accuracies are valid for measurements following an internal calibration. Averaged numbers assume dithering and averaging of 100 single-channel readings. Measurement accuracies are listed for operational temperatures within ±1 °C of internal calibration temperature and ±10 °C of external or factory-calibration temperature.

Dynamic Characteristics

Analog filters

Number

NI 6115 2

NI 6120 1

Type

NI 6115 3-pole Bessel

NI 6120 5-pole Bessel

Frequency

NI 6115 50 kHz and 500 kHz
(software-enabled)

NI 6120 100 kHz
(software-enabled)

Crosstalk -80 dB, DC to 100 kHz

Table 3. NI 6115 Analog Input Dynamic Characteristics

| Input Range | Bandwidth* (MHz) | SFDR Typ [†] (dB) | CMRR [‡] (dB) | System Noise [§] (LSB _{rms}) |
|-------------|------------------|----------------------------|------------------------|---|
| ±42 V | 5.5 | 78 | 34 | 0.35 |
| ±20 V | 4.4 | 78 | 40 | 0.45 |
| ±10 V | 7.2 | 81 | 46 | 0.35 |
| ±5 V | 4.8 | 81 | 52 | 0.35 |
| ±2 V | 4.8 | 85 | 60 | 0.45 |
| ±1 V | 4.4 | 85 | 66 | 0.60 |
| ±500 mV | 4.4 | 85 | 70 | 0.80 |
| ±200 mV | 4.1 | 81 | 72 | 1.3 |

* -3 dB frequency for input amplitude at 96% of the input range (-0.3 dB)
[†] Measured at 100 kHz with twelfth-order bandpass filter after signal source
[‡] DC to 60 Hz
[§] LSB_{rms}, not including quantization

Table 4. NI 6120 Analog Input Dynamic Characteristics

| Input Range | Bandwidth* (MHz) | SFDR Typ [†] (dB) | CMRR [‡] (dB) | System Noise [§] (LSB _{rms}) |
|-------------|------------------|----------------------------|------------------------|---|
| ±42 V | 1.0 | 95 | 60 | 1.2 |
| ±20 V | 1.0 | 96 | 68 | 1.2 |
| ±10 V | 1.0 | 95 | 76 | 1.2 |
| ±5 V | 1.0 | 95 | 82 | 1.5 |
| ±2 V | 1.0 | 96 | 90 | 1.7 |
| ±1 V | 1.0 | 94 | 95 | 2.0 |

Table 4. NI 6120 Analog Input Dynamic Characteristics (Continued)

| Input Range | Bandwidth* (MHz) | SFDR Typ† (dB) | CMRR‡ (dB) | System Noise§ (LSB _{rms}) |
|-------------|------------------|----------------|------------|-------------------------------------|
| ±500 mV | 1.0 | 90 | 100 | 2.2 |
| ±200 mV | 1.0 | 85 | 105 | 2.8 |

* -3 dB frequency for input amplitude at 10% of the input range (-20 dB)
 † Measured at 100 kHz with twelfth-order bandpass filter after signal source
 ‡ DC to 60 Hz
 § LSB_{rms}, not including quantization

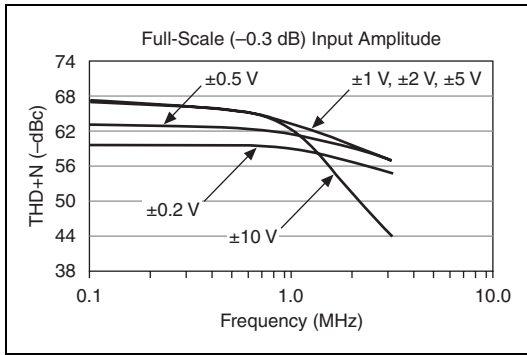


Figure 1. NI 6115 Total Harmonic Distortion Plus Noise (THD+N)

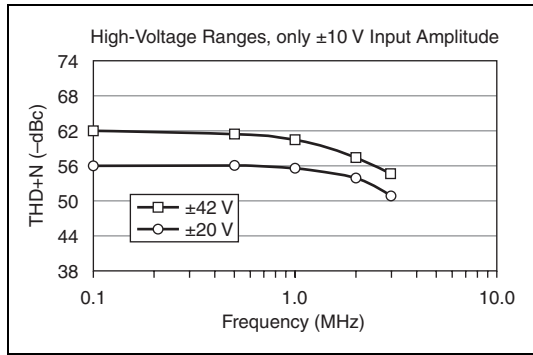


Figure 3. NI 6115 High-Voltage THD+N

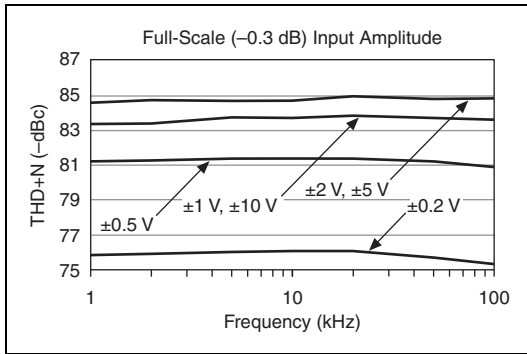


Figure 2. NI 6120 Total Harmonic Distortion Plus Noise (THD+N)

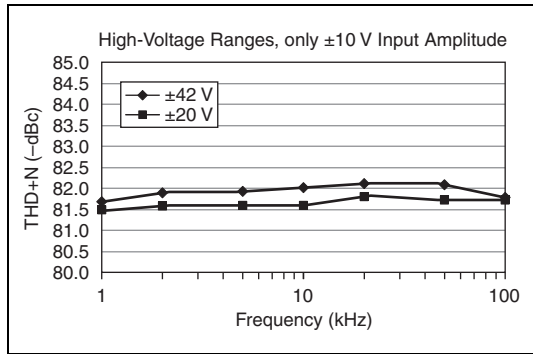


Figure 4. NI 6120 High-Voltage THD+N

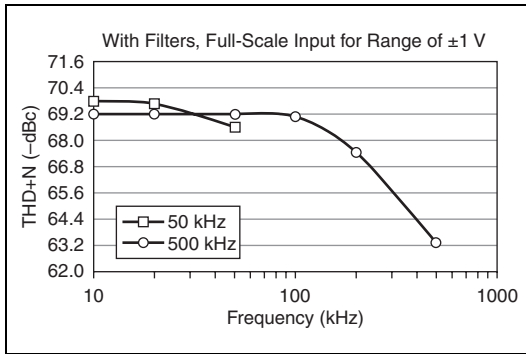


Figure 5. NI 6115 THD+N with Filters

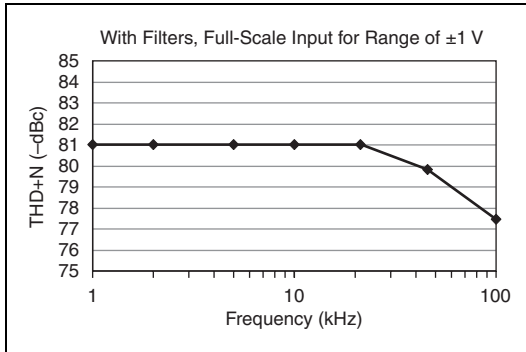


Figure 6. NI 6120 THD+N with Filters

Stability

Recommended warm-up time 15 min

Calibration interval 1 year

Offset temperature coefficient

Pregain

NI 6115 $\pm 12 \mu\text{V}/^\circ\text{C}$

NI 6120 $\pm 1.5 \mu\text{V}/^\circ\text{C}$

Postgain

NI 6115 $\pm 64 \mu\text{V}/^\circ\text{C}$

NI 6120 $\pm 2.1 \text{ LSB}/^\circ\text{C}$

Gain temperature coefficient

NI 6115 $\pm 21.3 \text{ ppm}/^\circ\text{C}$

NI 6120 $\pm 22.2 \text{ ppm}/^\circ\text{C}$

Analog Output

Output Characteristics

Number of channels 2 voltage

Resolution

NI 6115 12 bits, 1 in 4,096

NI 6120 16 bits, 1 in 65,536

Max update rate

1 channel 4 MS/s, system dependent

2 channel 2.5 MS/s, system dependent

Output buffer size 16 or 32 MS

Data transfers DMA, interrupts, programmed I/O

DMA modes Scatter-gather

DC Transfer Characteristics

INL

NI 6115 $\pm 0.5 \text{ LSB typ, } \pm 2 \text{ LSB max}$

NI 6120 $\pm 0.35 \text{ LSB typ, } \pm 1 \text{ LSB max}$

DNL

NI 6115 $\pm 0.25 \text{ LSB typ, } \pm 1 \text{ LSB max}$

NI 6120 $\pm 0.2 \text{ LSB typ, } \pm 1 \text{ LSB max}$

Offset, gain error

NI 6115 Refer to Table 5

NI 6120 Refer to Table 6

Table 5. NI 6115 Analog Output DC Accuracy Information

| Nominal Range at Full Scale (V) | Absolute Accuracy | | | | | Relative Accuracy | |
|---------------------------------|-------------------|---------|--------|-------------|-------------------|----------------------------------|-----------------------------|
| | % of Reading | | | Offset (mV) | Temp Drift (%/°C) | Absolute Acc. at Full Scale (mV) | Theoretical Resolution (mV) |
| | 24 Hours | 90 Days | 1 Year | | | | |
| ± 10 | 0.045 | 0.047 | 0.049 | 8.9 | 0.0008 | 14 | 4.9 |

Table 6. NI 6120 Analog Output DC Accuracy Information

| Nominal Range at Full Scale (V) | Absolute Accuracy | | | | | Relative Accuracy | |
|---------------------------------|-------------------|---------|--------|-------------|-------------------|----------------------------------|-----------------------------|
| | % of Reading | | | Offset (μV) | Temp Drift (%/°C) | Absolute Acc. at Full Scale (mV) | Theoretical Resolution (μV) |
| | 24 Hours | 90 Days | 1 Year | | | | |
| ±10 | 0.051 | 0.052 | 0.053 | 1,900 | 0.0006 | 6.7 | 310 |

Voltage Output

Ranges ±10 V

Output coupling DC

Output impedance 50 Ω ±5%

Current drive ±5 mA min

Output stability Any passive load

Protection Short-circuit to ground

Power-on output voltage (before software loads calibration values)

NI 6115 ±400 μV

NI 6120 ±80 μV

Initial power-up glitch

Magnitude ±2 V

Duration 200 ms

Dynamic Characteristics

Slew rate

NI 6115 300 V/μs

NI 6120 15 V/μs

Noise

NI 6115 600 μV_{rms}, DC to 5 MHz

NI 6120 100 μV_{rms}, DC to 1 MHz

Glitch energy at midscale transition

NI 6115 ±30 mV for 1 μs

NI 6120 ±10 mV for 1 μs

Settling time

NI 6115 300 ns to 0.01%

NI 6120 4 μs to ±1 LSB

Stability

Offset temperature coefficient

NI 6115 ±35 μV/°C

NI 6120 ±35 μV/°C

Gain temperature coefficient

NI 6115 ±56.9 ppm/°C

NI 6120 ±6.5 ppm/°C

Calibration

Level 5.000 V (±2.5 mV)
(actual value stored in EEPROM)

Temperature coefficient ±2.0 ppm/°C max

Long-term stability ±6 ppm/√1,000 h

Digital I/O

Number of channels 8 input/output

Compatibility TTL/CMOS

Table 7. Digital Logic Levels

| Level | Min | Max |
|--|--------|---------|
| Input low voltage | 0.0 V | 0.8 V |
| Input high voltage | 2.0 V | 5.0 V |
| Input low current (V _{in} = 0 V) | — | -320 μA |
| Input high current (V _{in} = 5 V) | — | 10 μA |
| Output low voltage (I _{OL} = 24 mA) | — | 0.4 V |
| Output high voltage (I _{OH} = -13 mA) | 4.35 V | — |

Power-on state Input (high-impedance)

Data transfers DMA, interrupts, programmed I/O

Input buffer 2,048 bytes

Output buffer 2,048 bytes

Transfer rate (1 word = 8 bits) 10 Mwords/s

Timing I/O

| | |
|---------------------------------|--|
| Number of channels | 2 up/down counter/timers, 1 frequency scaler |
| Resolution | |
| Counter/timers | 24 bits |
| Frequency scaler | 4 bits |
| Compatibility | TTL/CMOS |
| Base clocks available | |
| Counter/timers | 20 MHz, 100 kHz |
| Frequency scaler | 10 MHz, 100 kHz |
| Base clock accuracy | ±0.01% |
| Max source frequency | 20 MHz |
| Min source pulse duration | 10 ns, edge-detect mode |
| Min gate pulse duration | 10 ns, edge-detect mode |
| Data transfers | DMA, interrupts, programmed I/O |
| DMA modes | Scatter-gather |

Triggers

Analog Trigger

| | |
|--------------------------------------|--|
| Source | All analog input channels, external trigger (PFI 0/AI START TRIG) |
| Level | |
| Internal | ± full-scale |
| External | ±10 V |
| Slope | Positive or negative (software-selectable) |
| Resolution | |
| NI 6115 | 8 bits, 1 in 256 |
| NI 6120 | 12 bits, 1 in 4,096 |
| Hysteresis | Programmable |
| Bandwidth (–3 dB) | 5 MHz internal/external |
| External input (PFI 0/AI START TRIG) | |
| Impedance | 10 k Ω |
| Coupling | AC/DC |
| Protection | –0.5 V to ($V_{CC} + 0.5$) V when configured as a digital signal, ±35 V when configured as an analog trigger signal or disabled, ±35 V powered off |

Digital Trigger

| | |
|---------------------|------------------------|
| Compatibility | TTL |
| Response | Rising or falling edge |
| Pulse width | 10 ns min |

RTSI Trigger Lines (PCI Only)

| | |
|----------------------------|---|
| Trigger lines <0..6> | 7 |
| RTSI clock | 1 |

PXI Trigger Bus (PXI Only)

| | |
|----------------------------|---|
| Trigger lines <0..6> | 7 |
| Star trigger | 1 |

Bus Interface

| | |
|------------|---------------|
| Type | Master, slave |
|------------|---------------|

Power Requirement

| | |
|--------------------------------------|------------------------------|
| +5 VDC (±5%) | |
| NI 6115 | 2.2 A |
| NI 6120 | 3.0 A |
| +3.3 V | 0.8 A |
| Power available at I/O connector ... | +4.65 to +5.25 VDC at 1 A |

Physical

| | |
|---------------------------------------|---|
| Dimensions (not including connectors) | |
| NI PCI-6115/6120 | 31.2 cm × 10.6 cm (12.3 in. × 4.2 in.) |
| NI PXI-6115/6120 | 16 cm × 10 cm (6.3 in. × 3.9 in.) |
| I/O connector | .68-pin male SCSI-II type |

Maximum Working Voltage

| | |
|--|----------------------------------|
| Maximum working voltage refers to the signal voltage plus the common-mode voltage. | |
| Channel-to-earth | .42 V, Measurement Category I |
| Channel-to-channel | .42 V, Measurement Category I |

Environmental

| | |
|---|--------------|
| The NI 6115/6120 is intended for indoor use only. | |
| Operating temperature | 0 to 50 °C |
| Storage temperature | –20 to 70 °C |

| | |
|------------------------|--------------------------------|
| Humidity..... | 10 to 90% RH, noncondensing |
| Maximum altitude | 2,000 m |
| Pollution Degree..... | 2 |

Safety

The NI 6115/6120 is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA 61010-1



Note For UL and other safety certifications, refer to the product label, or visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

The NI 6115/6120 is designed to meet the requirements of the following standards of EMC for electrical equipment for measurement, control, and laboratory use:

- EN 61326 EMC requirements; Minimum Immunity
- EN 55011 Emissions; Group 1, Class A
- CE, C-Tick, ICES, and FCC Part 15 Emissions; Class A



Note For EMC compliance, operate this device with shielded cabling.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

- 73/23/EEC; Low-Voltage Directive (safety)
- 89/336/EEC; Electromagnetic Compatibility Directive (EMC)



Note Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Waste Electrical and Electronic Equipment (WEEE)



EU Customers At the end of their life cycle, all products *must* be sent to a WEEE recycling center. For more information about WEEE recycling centers and National Instruments WEEE initiatives, visit ni.com/environment/weee.htm.

| | | | |
|---------------------|----|----|--------------------|
| AI 0 – | 34 | 68 | AI 0 + |
| AI 1 + | 33 | 67 | AI 0 GND |
| AI 1 GND | 32 | 66 | AI 1 – |
| AI 2 – | 31 | 65 | AI 2 + |
| AI 3 + | 30 | 64 | AI 2 GND |
| AI 3 GND | 29 | 63 | AI 3 – |
| NC | 28 | 62 | NC |
| NC | 27 | 61 | NC |
| NC | 26 | 60 | NC |
| NC | 25 | 59 | NC |
| NC | 24 | 58 | NC |
| NC | 23 | 57 | NC |
| AO 0 | 22 | 56 | NC |
| AO 1 | 21 | 55 | AO GND |
| NC | 20 | 54 | AO GND |
| P0.4 | 19 | 53 | D GND |
| D GND | 18 | 52 | P0.0 |
| P0.1 | 17 | 51 | P0.5 |
| P0.6 | 16 | 50 | D GND |
| D GND | 15 | 49 | P0.2 |
| +5 V | 14 | 48 | P0.7 |
| D GND | 13 | 47 | P0.3 |
| D GND | 12 | 46 | AI HOLD COMP |
| PFI 0/AI START TRIG | 11 | 45 | EXT STROBE* |
| PFI 1/AI REF TRIG | 10 | 44 | D GND |
| D GND | 9 | 43 | PFI 2/AI CONV CLK |
| +5 V | 8 | 42 | PFI 3/CTR 1 SOURCE |
| D GND | 7 | 41 | PFI 4/CTR 1 GATE |
| PFI 5/AO SAMP CLK* | 6 | 40 | CTR 1 OUT |
| PFI 6/AO START TRIG | 5 | 39 | D GND |
| D GND | 4 | 38 | PFI 7/AI SAMP CLK |
| PFI 9/CTR 0 GATE | 3 | 37 | PFI 8/CTR 0 SOURCE |
| CTR 0 OUT | 2 | 36 | D GND |
| FREQ OUT | 1 | 35 | D GND |

NC = No Connect

Figure 7. NI 6115/6120 Pinout

National Instruments, NI, ni.com, and LabVIEW are trademarks of National Instruments Corporation. Refer to the *Terms of Use* section on ni.com/legal for more information about National Instruments trademarks. Other product and company names mentioned herein are trademarks or trade names of their respective companies. For patents covering National Instruments products, refer to the appropriate location: **Help»Patents** in your software, the `patents.txt` file on your CD, or ni.com/patents.